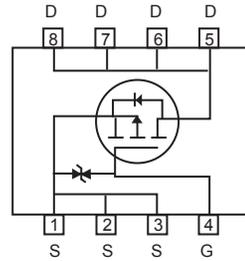
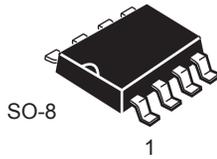


P-Channel Enhancement Mode Field Effect Transistor

PRELIMINARY

FEATURES

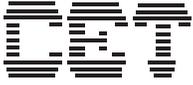
- -30V, -15A, $R_{DS(ON)} = 7m\Omega$ @ $V_{GS} = -10V$.
 $R_{DS(ON)} = 15m\Omega$ @ $V_{GS} = -4.5V$.
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handling capability.
- Lead free product is acquired.
- Surface mount Package.
- ESD Protected: 4000 V



ABSOLUTE MAXIMUM RATINGS $T_A = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Limit	Units
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	-15	A
Drain Current-Pulsed ^a	I_{DM}	-60	A
Maximum Power Dissipation	P_D	2.5	W
Operating and Store Temperature Range	T_J, T_{stg}	-55 to 150	$^\circ\text{C}$

Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Ambient ^b	$R_{\theta JA}$	50	$^\circ\text{C/W}$



CEM3053

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

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Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -30V, V_{GS} = 0V$			-10	μA
Gate Body Leakage Current, Forward	I_{GSSF}	$V_{GS} = 16V, V_{DS} = 0V$			10	μA
Gate Body Leakage Current, Reverse	I_{GSSR}	$V_{GS} = -16V, V_{DS} = 0V$			-10	μA
On Characteristics ^c						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D = -250\mu A$	-0.8		-2.0	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -6.5A$		5.5	7.0	$m\Omega$
		$V_{GS} = -4.5V, I_D = -6.5A$		10	15	$m\Omega$
Dynamic Characteristics ^d						
Forward Transconductance	g_{FS}	$V_{DS} = -5V, I_D = -6A$		10		S
Input Capacitance	C_{iss}	$V_{DS} = -10V, V_{GS} = 0V, f = 1MHz$		9770		pF
Output Capacitance	C_{oss}			1010		pF
Reverse Transfer Capacitance	C_{rss}			770		pF
Switching Characteristics ^d						
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -15V, I_D = -6.5A, V_{GS} = -10V, R_{GEN} = 4.7\Omega$		16.8	33.6	ns
Turn-On Rise Time	t_r			12.8	25.6	ns
Turn-Off Delay Time	$t_{d(off)}$			316	632	ns
Turn-Off Fall Time	t_f			131.3	262.6	ns
Total Gate Charge	Q_g	$V_{DS} = -24V, I_D = -13A, V_{GS} = -10V$		148	192.4	nC
Gate-Source Charge	Q_{gs}			13.9		nC
Gate-Drain Charge	Q_{gd}			28.5		nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Current ^b	I_S				-1	A
Drain-Source Diode Forward Voltage ^c	V_{SD}	$V_{GS} = 0V, I_S = -1A$			-1.2	V
Notes : <input type="checkbox"/> a.Repetitive Rating : Pulse width limited by maximum junction temperature. <input type="checkbox"/> b.Surface Mounted on FR4 Board, $t \leq 10$ sec. <input type="checkbox"/> c.Pulse Test : Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$. <input type="checkbox"/> d.Guaranteed by design, not subject to production testing. <input type="checkbox"/> <input type="checkbox"/>						



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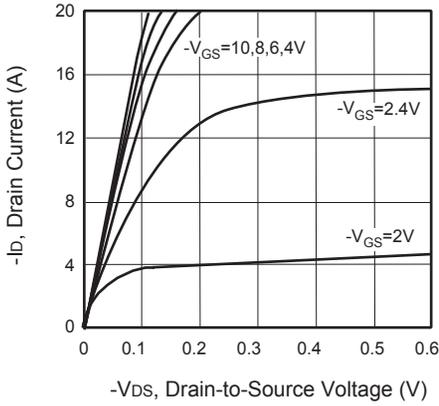


Figure 1. Output Characteristics

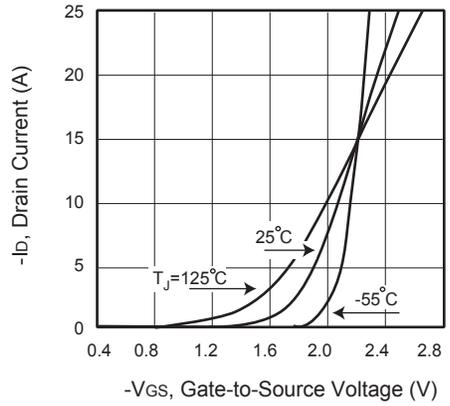


Figure 2. Transfer Characteristics

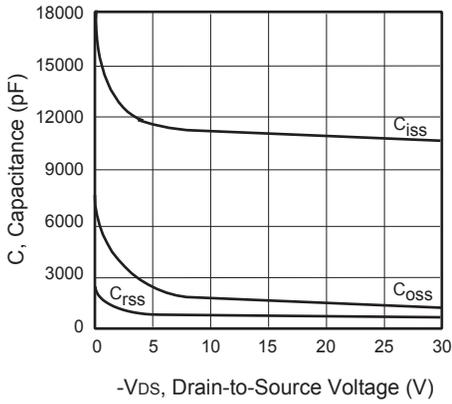


Figure 3. Capacitance

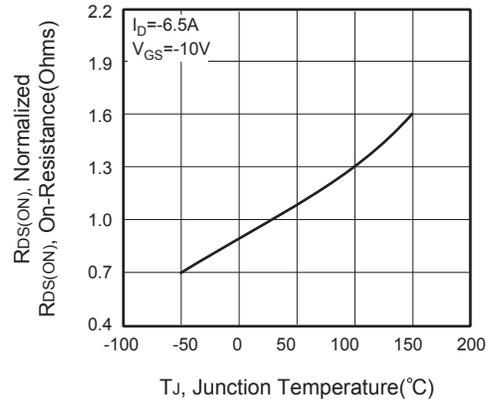


Figure 4. On-Resistance Variation with Temperature

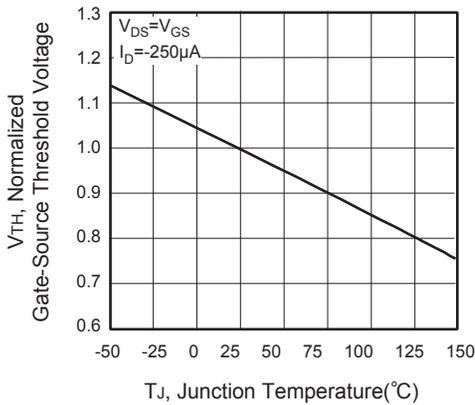


Figure 5. Gate Threshold Variation with Temperature

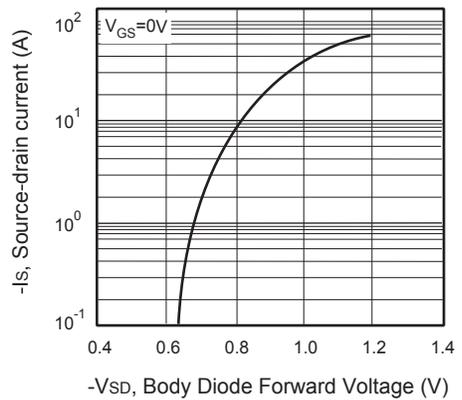


Figure 6. Body Diode Forward Voltage Variation with Source Current



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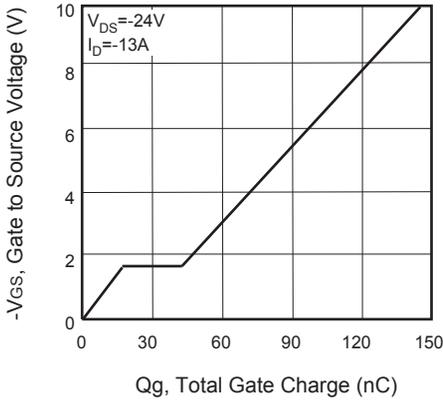


Figure 7. Gate Charge

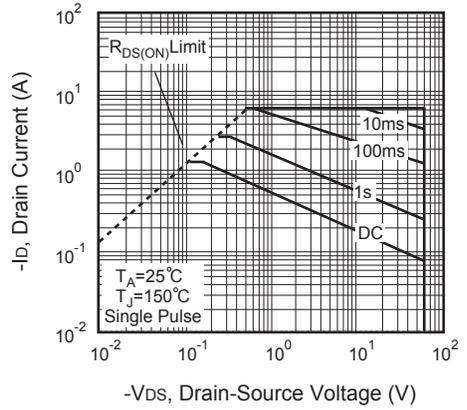


Figure 8. Maximum Safe Operating Area

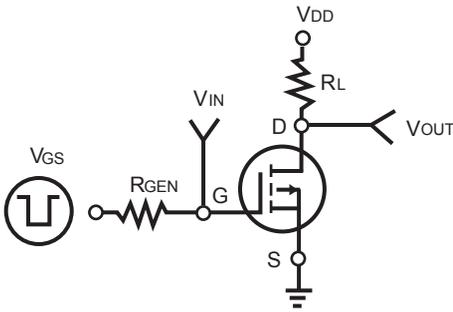


Figure 9. Switching Test Circuit

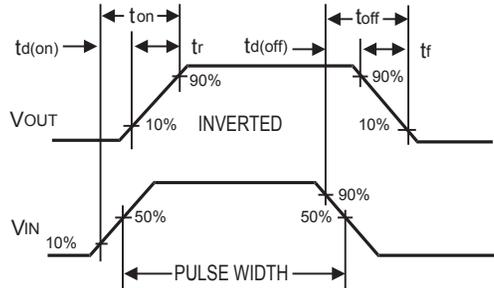


Figure 10. Switching Waveforms

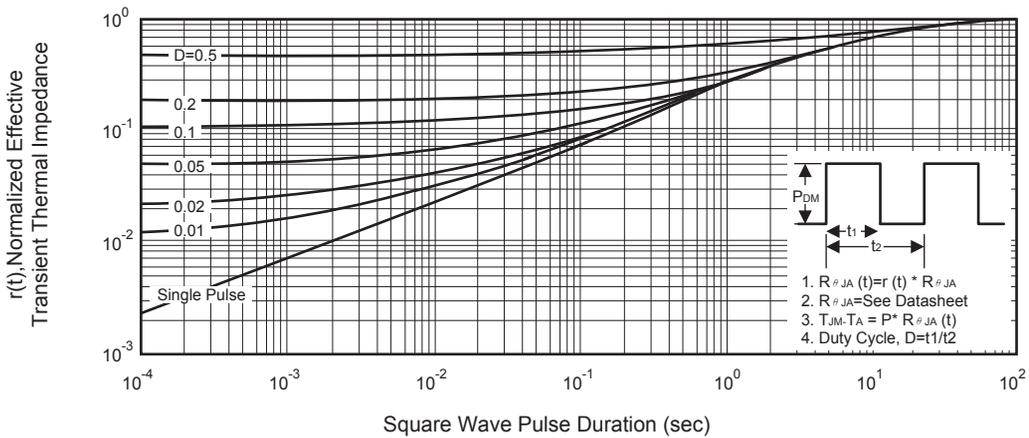


Figure 11. Normalized Thermal Transient Impedance Curve